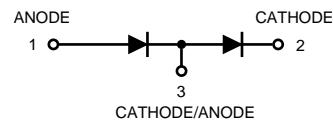
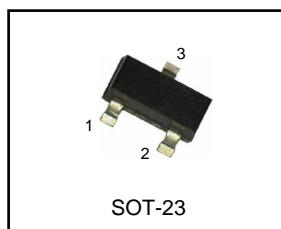




Dual Series Switching Diode

BAV99



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Continuous Reverse Voltage	VR	70	Vdc
Peak Forward Current	IF	215	mAdc
Peak Forward Surge Current	IFM(surge)	500	mAdc
Repetitive Peak Reverse Voltage	VRRM	70	Vdc
Average Rectified Forward Current ⁽¹⁾ (averaged over any 20 ms period)	IF(AV)	715	mAdc
Repetitive Peak Forward Current	IFRM	450	mAdc
Non-Repetitive Peak Forward Current t=1.0 uS t=1.0 mS t=1.0 S	IFSM	2.0 1.0 0.5	A

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max.	Unit
Total Device Dissipation FR-5 Board ⁽¹⁾ TA=25°C Derate above 25°C	PD	225 1.8	mW mW / °C
Thermal Resistance, Junction to Ambient	R _{θJA}	556	°C / W
Total Device Dissipation Alumina Substrate, ⁽²⁾ TA=25°C Derate above 25°C	PD	300 2.4	mW mW / °C
Thermal Resistance, Junction to Ambient	R _{θJA}	417	°C / W
Junction and Storage Temperature	TJ,TSTG	-65 to +150	°C

DEVICE MARKING

BAV99=A7

ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted) (Continued) (EACH DIODE)

Characteristic	Symbol	Min.	Max.	Unit
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OFF CHARACTERISTICS

Reverse Breakdown Voltage (I _{BR} =100uAdc)	V _(BR)	70	-	Vdc
Forward Voltage (IF=1.0 mAdc) (IF=10 mAdc) (IF=50 mAdc) (IF=150 mAdc)	VF	- - - -	715 855 1000 1250	mVdc
Reverse Voltage Leakage Current (VR=70 Vdc) (VR=25 Vdc, TJ=150°C) (VR=70 Vdc, TJ=150°C)	IR	- - -	2.5 30 50	uAdc
Diode Capacitance (VR=0, f=1.0MHz)	C _J	-	1.5	pF
Reverse Recovery Time (IF=IR=10 mAdc, IR(REC)=1.0mA, RL=50Ω)	trr	-	6.0	nS
Forward Recovery Voltage (IF=10 mAdc, tr=20nS)	V _F R	-	1.75	Vdc

(1) FR-5=1.0 x 0.75 x 0.062in.

(2) Alumina=0.4 x 0.3 x 0.024in. 99.5% alumina.



FIGURE 1. RECOVERY TIME EQUIVALENT TEST CIRCUIT

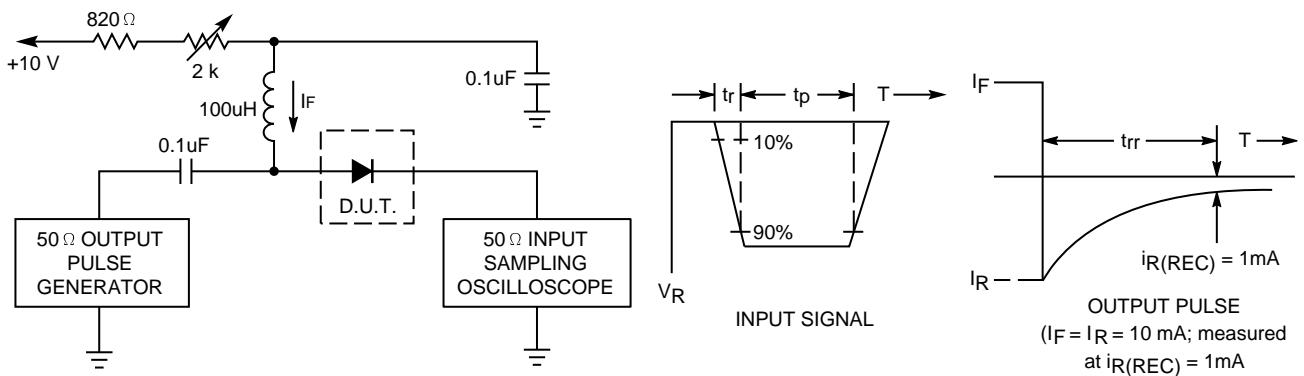


FIGURE 2. FORWARD VOLTAGE

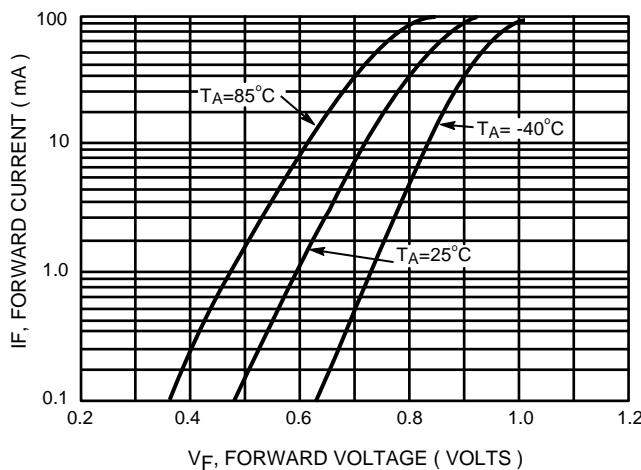


FIGURE 3. LEAKAGE CURRENT

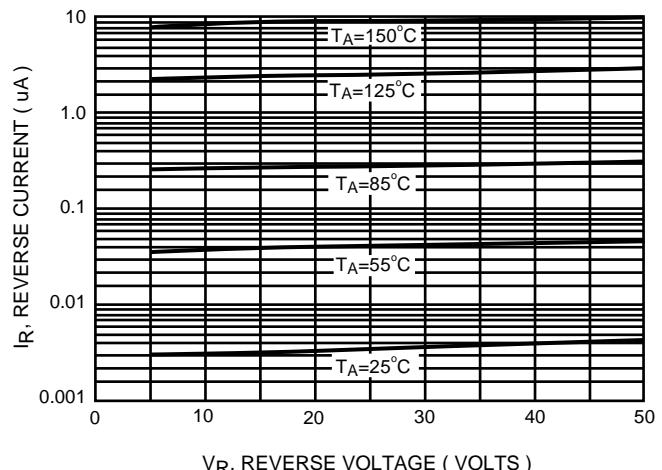


FIGURE 4. CAPACITANCE

